

# Stable and efficient Sb<sub>2</sub>Se<sub>3</sub> solar cells with solution-processed NiO<sub>x</sub> hole-transport layer

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## ABSTRACT

Sb<sub>2</sub>Se<sub>3</sub> is a promising absorber material for thin-film solar cells owing to its earth-abundant and non-toxic constituents, superior optoelectronic properties, and unique one-dimensional crystal structure. To further increase the power conversion efficiency of the Sb<sub>2</sub>Se<sub>3</sub>, we fabricated an n-i-p structure by integrating a solution-processed NiO<sub>x</sub> hole-transport layer (HTL) into Sb<sub>2</sub>Se<sub>3</sub> solar cells to enhance the carrier collection. In this study, we systematically screen the thickness of NiO<sub>x</sub> HTL and demonstrate an improved average power conversion efficiency from 6.12% to 7.15% with a 50 nm NiO<sub>x</sub> HTL. The mechanism associated with the improved device performance was characterized through the microstructure of the material, device physics, and interface electronic behaviors. It is also shown that the low-cost and scalable solution-processed NiO<sub>x</sub> HTL can improve device stability under an accelerated stress test. Thus, this work paves a way to further improve the performance of antimony chalcogenides-based solar cells via tailoring the inorganic HTL.

## 1. Introduction

Photovoltaics (PV, i.e., solar cells) technology offers clean, affordable, and sustainable energy via directly converting sunlight into electricity to address the global energy crisis and alleviate issues associated with burning fossil fuels (Crabtree and Lewis, 2007). From the traditional Si wafer-based technology to the thin-film-based CdTe and CIGS, along with the halide perovskite solar cells, all these PV technologies already demonstrate power conversion efficiency (PCE) of over 22% (Green and Bremner, 2017; Green et al., 2019; Wong et al., 2019). Nevertheless, the rigid nature of Si wafer, the toxicity of Cd, and the high cost of In and Ga, along with the instability of halide perovskite pose challenges for the PV development (Kamruzzaman et al., 2017; Zhou et al., 2014). Recently, Sb<sub>2</sub>Se<sub>3</sub> has attracted extensive attention as a light-absorber material for solar cells with a theoretical PCE of ~ 32% based on the Shockley-Queisser limit (Green and Bremner, 2017) due to its superior optoelectronic properties, such as the high absorption coefficient ( $>10^5 \text{ cm}^{-1}$ ) in the visible region (Zeng et al., 2016), and a suitable bandgap (1.1 ~ 1.2 eV) (Zeng et al., 2016; Zhou et al., 2014; Zhou et al., 2015). Besides, Sb<sub>2</sub>Se<sub>3</sub> is a stable and low-toxic binary

compound with a stable orthorhombic crystalline phase in ambient air, and thus, it avoids the complex phase control during manufacturing as encountered in CIGS technology and instability of perovskite (Zhou et al., 2014). More importantly, noncubic Sb<sub>2</sub>Se<sub>3</sub> is comprised of one-dimensional ribbons (Sb<sub>4</sub>Se<sub>6</sub>)<sub>n</sub> stacked by the weak van der Waals (vdW) (Guo et al., 2018; Zeng et al., 2016; Zhou et al., 2015), where the grain boundaries (GBs) area can be self-passivated without dangling bonds to prevent the common recombination loss due to GBs in typical three-dimensional PV technologies (Guo et al., 2018; Zhou et al., 2015).

So far, the PCE of Sb<sub>2</sub>Se<sub>3</sub> solar cell has rapidly improved from less than 1% to 10% within one decade through various growth techniques such as chemical bath deposition (CBD), (Messina et al., 2009) hydrazine (N<sub>2</sub>H<sub>4</sub>) solution-processed method (Zhou et al., 2014), rapid thermal evaporation (RTE) (Zhou et al., 2015), close-Space Sublimation, (Li et al., 2018; Li et al., 2019b) and hydrothermal deposition method (Tang et al., 2020). Despite the stunning progress made in the area, the efficiency improvement is largely plagued by its open-circuit voltage ( $V_{oc}$ ) deficit due to the low doping density of Sb<sub>2</sub>Se<sub>3</sub> (Chen and Tang, 2020; Chen et al., 2017; Hobson et al., 2020). To address this issue, one strategy is to introduce a hole-transport layer (HTL) to effectively extract

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the photogenerated holes. Previous studies have successfully employed many hole-transport materials into  $\text{Sb}_2\text{Se}_3$  solar cells. For instance, organic PCDTBT, Spiro-OMeTAD, and P3HT have been reported as hole-transport material (HTM) in  $\text{Sb}_2\text{Se}_3$  sensitized solar cells, which can improve the device performance significantly (Choi et al., 2014; Gujjarro et al., 2012; Ju et al., 2020; Li et al., 2018; Tang et al., 2020). However, these organic HTMs face stability issues. Thus, inorganic HTMs such as colloidal quantum dot (QD) PbS, and CuSCN were introduced to  $\text{Sb}_2\text{Se}_3$  solar cells (Chen et al., 2017; Li et al., 2019a). However, QD PbS has the issue of the toxicity of Pb and CuSCN may introduce fast diffused Cu into the  $\text{Sb}_2\text{Se}_3$ . Taking all these into consideration, it is of great significance to develop a non-toxic and stable HTM for  $\text{Sb}_2\text{Se}_3$  solar cells for further performance improvement while maintaining its long-term stability.

Traditionally,  $\text{NiO}_x$  is an ambient air-stable and nontoxic wide-bandgap p-type HTL, and, it has been successfully demonstrated in high-efficiency perovskite solar cells through the solution process (Lee et al., 2020; Park et al., 2015; Xu et al., 2015; Yin et al., 2016; You et al., 2016; Zhu et al., 2014). As for the antimony chalcogenide solar cells, solution-processed  $\text{NiO}_x$  nanoparticles show promising hole transport capability in the  $\text{Sb}_2\text{Se}_3$  solar cells (Jin et al., 2018). However, for the  $\text{Sb}_2\text{Se}_3$  solar cells, there are only limited results using  $\text{NiO}_x$ , such as thermally evaporated thin  $\text{NiO}_x$  buffer layer for the Ni back contact development of  $\text{Sb}_2\text{Se}_3$  solar cells (Zhang et al., 2019). No systematic investigation of the solution-processed  $\text{NiO}_x$  HTL for the  $\text{Sb}_2\text{Se}_3$  solar cell has been done yet.

In this paper, we successfully demonstrated the solution-processed  $\text{NiO}_x$  nanoparticles as an HTL on  $\text{Sb}_2\text{Se}_3$  thin-film solar cells with improved device performance. We employed a thermal decomposition method to synthesize the  $\text{NiO}_x$  nanoparticles which were then dispersed in deionized water (DIW) to form  $\text{NiO}_x$  nanoparticle ink.  $\text{NiO}_x$  HTL film was then deposited on  $\text{Sb}_2\text{Se}_3$  film via the spin coating method, where the spinning speed was regulated to control the  $\text{NiO}_x$  thickness. By tailoring the  $\text{NiO}_x$  HTL thickness, the champion  $\text{Sb}_2\text{Se}_3$  solar cell delivered a PCE of 7.29%, with  $V_{OC}$  of 0.41 V,  $J_{SC}$  of 30.94  $\text{mA}/\text{cm}^2$ , and FF of 57.26%. The improved performance originated from the reduced carrier recombination at the  $\text{Sb}_2\text{Se}_3/\text{NiO}_x$  interface due to the  $\text{NiO}_x$  passivation effect. Moreover, the device with  $\text{NiO}_x$  HTL maintains improved stability after light soaking for 140 h.

## 2. Experimental section

### 2.1. $\text{NiO}_x$ nanopowder fabrication and solution preparation

0.05 mol  $\text{Ni}(\text{NO}_3)_2 \cdot 6\text{H}_2\text{O}$  was dissolved in 10 mL deionized water (DIW). Then NaOH solution was added into the as-dissolved  $\text{Ni}(\text{NO}_3)_2$  solution under vigorous stirring until the solution turned into a turbid green color with a pH of 10. The solution was then filtered to obtain the precipitation which was washed by DIW to get rid of the impurities. This step was repeated at least four times to guarantee the purity of the precipitates. The wet precipitate was dried at 80 °C for 8 h and then ground into powder, which was then annealed in air at 270 °C for 2 h to get the  $\text{NiO}_x$  nanopowders.  $\text{NiO}_x$  nanopowders were dissolved into DIW to form an ink of  $\sim 20 \text{ mg}/\text{mL}$  concentration. The solution was ultrasonically treated at room temperature prior to the deposition.

### 2.2. $\text{Sb}_2\text{Se}_3$ film deposition

Commercial fluorine-doped  $\text{SnO}_2$  (FTO) coated soda-lime glass (TEC 10, NSG, US) was cleaned with detergent, acetone, isopropanol, and deionized water in sequence in the ultrasonic bath. CdS window layer was deposited on the cleaned FTO glass via a chemical bath deposition as reported elsewhere (Guo et al., 2018). The  $\text{Sb}_2\text{Se}_3$  thin films with 1  $\mu\text{m}$ -thickness were grown in a close space sublimation (CSS) system under vacuum with deposition pressure of  $\sim 10 \text{ mTorr}$ , where the top and bottom heaters were controlled at 300 and 550 °C for deposition,

respectively. After  $\text{Sb}_2\text{Se}_3$  film deposition, the CSS system was switched off to naturally cool down the system.  $\text{NiO}_x$  HTLs were deposited via spin coating with various spinning speeds (500 to 5000 rpm) for 30 s to control the film thickness. After spin coating, the  $\text{NiO}_x$  coated samples were dried on a hotplate in the air at 80 °C for 5 mins.

### 2.3. Materials characterization

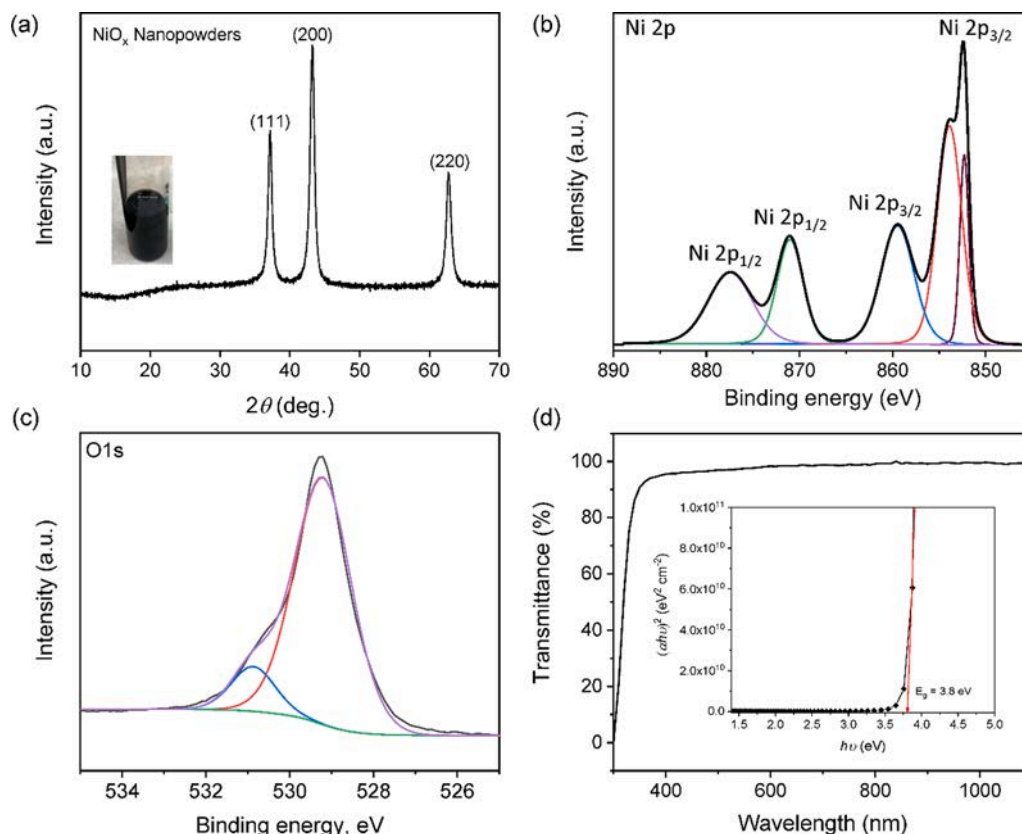
The thickness of the  $\text{Sb}_2\text{Se}_3$  films was estimated by the surface profilometer (KLA Tencor D-500) and validated by the SEM cross-section image. The crystal structure of  $\text{NiO}_x$  nanopowder and  $\text{Sb}_2\text{Se}_3$  films were characterized by X-ray diffraction (XRD) system (Philips X'Pert) with Cu K $\alpha$  radiation. The film morphology and chemical composition were characterized by the scanning electron microscope (SEM, JEOL 7000) and energy-dispersive spectroscopy (EDS) attached to the SEM. X-ray photoelectron spectroscopy (XPS) was collected using the Kratos Axis 165 XPS with Al source. The transmittance spectra were characterized by UV–Vis spectroscopy (Shimadzu UV1800).

### 2.4. Solar cell fabrication and measurement

The  $\text{NiO}_x$  HTLs were spin-coated on the as-deposited  $\text{Sb}_2\text{Se}_3$  films with various thicknesses by manipulating the spin rotation speed. Au electrode was deposited using a shadow mask (area 0.09  $\text{cm}^2$ ) via the sputtering system with a 2 in. Au target. The current density–voltage ( $J$ - $V$ ) curve of the fabricated solar cells was characterized using a solar simulator (Newport, Oriel Class AAA 94063A, 1000 Watt Xenon light source) with a source meter (Keithley 2420) at 100  $\text{mW}/\text{cm}^2$  AM 1.5 G irradiation. A calibrated Si-reference cell and meter (Newport, 91150 V, certified by NREL) was used to calibrate the solar simulator prior to the measurement. External Quantum Efficiency (EQE) of solar cells was obtained by the solar cell spectra response measurement system (QE-T, Enli Technology, Co. Ltd). Capacitance–Voltage ( $C$ - $V$ ) measurement was performed in the dark at room temperature using a Solartron Analytical 1260 impedance analyzer equipped with a 1296 dielectric interface at a frequency of 10 kHz, and the AC amplitude was 30 mV. DC bias was swept from  $-1$  to 0.3 V. Electrochemical impedance spectroscopy (EIS) measurement was conducted on Solartron Analytical 1260 impedance analyzer at a bias potential of 0.5 V in the dark with the frequency ranging from  $10^2$  to  $10^6$  Hz. A light-soaking test was performed in a home-made aging chamber with a 1 sun light source and temperature at  $\sim 85$  °C.

## 3. Results and discussion

Fig. 1a shows the XRD pattern of the as-prepared  $\text{NiO}_x$  nanopowders.  $\text{NiO}_x$  solutions were synthesized by fully dispersing  $\text{NiO}_x$  nanoparticles into DIW in the ultrasonic bath (inset of Fig. 1a). The typical cubic structure of the  $\text{NiO}_x$  has been determined through the three (111), (200), and (220) XRD peaks with 2 theta degrees of 37.2°, 43.2°, and 62.7°, respectively (Jin et al., 2018). The nanoparticle size has been calculated to be  $\sim 8 \text{ nm}$  using the Scherrer equation,  $\tau = K\lambda/\beta\cos\theta$ , where  $\tau$  is the crystalline size,  $K$  is the shape factor ( $\sim 0.9$ ),  $\beta$  is the line broadening at half the maximum intensity (FWHM), and  $\theta$  is the Bragg angle. The elemental composition of the deposited  $\text{NiO}_x$  films was characterized by XPS. Fig. 1b and 1c are high-resolution XPS spectra of Ni 2p and O 1s core levels and the corresponding fitted results of Gaussian-Lorentzian curves after subtraction of a Shirley baseline, respectively. The strong peaks that appear at a binding energy of 854.1 eV (Fig. 1b) and 529.3 eV (Fig. 1c) are assigned to  $\text{Ni}^{2+}$  and  $\text{O}^{2-}$  states in the standard Ni-O octahedral bonding configuration in cubic rock-salt nickel oxide, respectively. In the high binding energy region, the peak observed at 855.8 eV is designated to the  $\text{Ni}^{3+}$  in  $\text{Ni}_2\text{O}_3$  and  $\text{NiOOH}$  as a result of the  $\text{Ni}^{2+}$  vacancy. This indicates the as-deposited  $\text{NiO}_x$  is non-stoichiometric with abundant  $\text{Ni}^{2+}$  vacancies, which renders the as-prepared  $\text{NiO}_x$  with a desired hole transporting ability (Jin et al.,

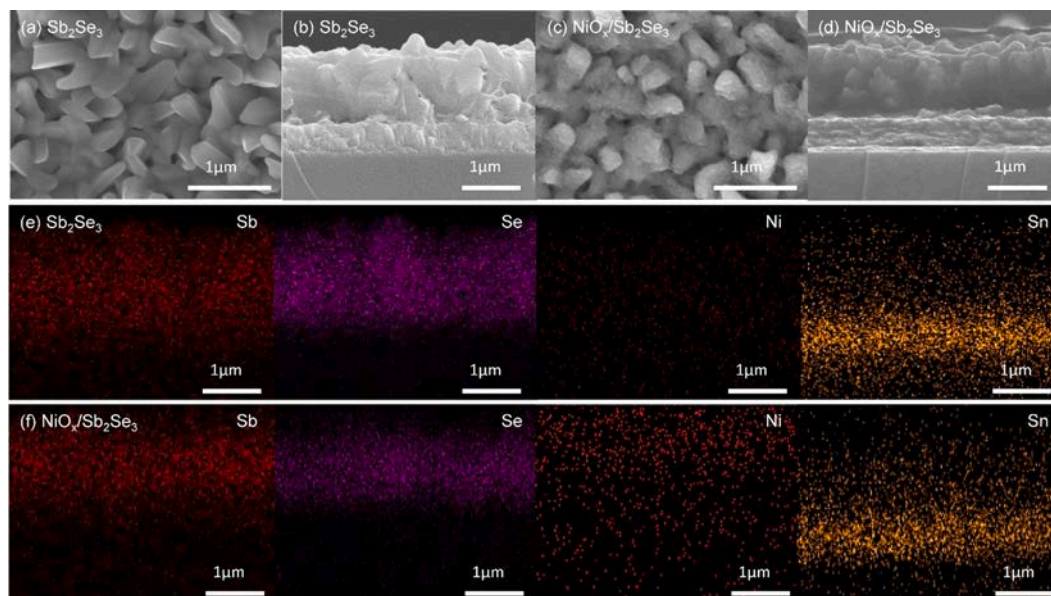


**Fig. 1.** (a) XRD pattern of the as-prepared  $\text{NiO}_x$  nanoparticles and the inset is the optical image of  $\text{NiO}_x$  ink. (b) XPS of Ni  $2p_{3/2}$  and (c) O  $1s$  core level for  $\text{NiO}_x$  film. (d) The transmittance of  $\text{NiO}_x$  film with Tauc plot inserted.

2018). The transmittance of the  $\text{NiO}_x$  film spin-coated on the glass substrate was characterized by the UV–Vis system, as shown in Fig. 1d. The as-deposited  $\text{NiO}_x$  film ( $\sim 50$  nm) shows a high transmittance of over 93% in the region of  $\sim 350$  to  $1100$  nm, suggesting that the  $\text{NiO}_x$  films have limited light absorption and may not impact the light absorption of the  $\text{Sb}_2\text{Se}_3$  absorber. The bandgap derived from the transmittance shown in the inset of Fig. 1d indicates the as-deposited  $\text{NiO}_x$  film exhibits a wide

bandgap of 3.8 eV.

To ascertain the coverage of the  $\text{NiO}_x$  on the  $\text{Sb}_2\text{Se}_3$  film and the  $\text{NiO}_x/\text{Sb}_2\text{Se}_3$  interface, we used the SEM equipped with EDS to characterize the  $\text{NiO}_x$  coated  $\text{Sb}_2\text{Se}_3$  films. As shown in Fig. 2a–b, the as-deposited pristine  $\text{Sb}_2\text{Se}_3$  film with thickness  $\sim 1$   $\mu\text{m}$  exhibits columnar rod-structured grains with  $\sim 300$  nm on average, which could be associated with the orthorhombic crystal structure of the  $\text{Sb}_2\text{Se}_3$ .



**Fig. 2.** Top-view SEM images of (a) pristine  $\text{Sb}_2\text{Se}_3$  and (c)  $\text{NiO}_x$  coated  $\text{Sb}_2\text{Se}_3$  films. Cross-sectional SEM images of (b)  $\text{Sb}_2\text{Se}_3$  and (d)  $\text{NiO}_x/\text{Sb}_2\text{Se}_3$  with the corresponding EDS elemental mapping images of constituent elements.



Particularly, the as-deposited  $\text{Sb}_2\text{Se}_3$  presents a rough surface with clear voids on the surface, which may damage the interface between  $\text{Sb}_2\text{Se}_3$  and the back contact. The atomic ratio of Se to Sb is close to 1.5 (60.36:39.64) determined by the EDS. The  $\text{NiO}_x$  nanoparticles coating on the  $\text{Sb}_2\text{Se}_3$  film is uniform but still preserves a slightly columnar structure, as indicated in Fig. 2c-d. Especially, the  $\text{NiO}_x$  could effectively fill the voids on the surface of the as-deposited  $\text{Sb}_2\text{Se}_3$ , which could significantly impact the photogenerated carrier transport in the interface of  $\text{Sb}_2\text{Se}_3$  and Au back contact. The corresponding EDS mapping for the cross-section of the Fig. 2b and 2d are shown in Fig. 2e and 2f, respectively, and it is shown that the  $\text{NiO}_x$  is uniformly spread on the top of the  $\text{Sb}_2\text{Se}_3$  layer.

To investigate the effect of the  $\text{NiO}_x$  hole transport properties in the  $\text{Sb}_2\text{Se}_3$  solar cells, Au electrodes with  $\sim 80$  nm thickness were sputtered on the  $\text{Sb}_2\text{Se}_3$  and  $\text{NiO}_x$  coated  $\text{Sb}_2\text{Se}_3$  films to form a solar cell device in a superstrate configuration: FTO/CdS/ $\text{Sb}_2\text{Se}_3$ / $\text{NiO}_x$ /Au, as shown in Fig. 3a. The energy band diagram of the device is plotted in Fig. 3b, where the  $\text{NiO}_x$  could promote the hole collection in the backside and block the electron transport to the back contact. This electron reflecting role is similar to the ZnTe back contact for the CdTe solar cells to make an ohmic contact (Niles et al., 1992), which could increase the photogenerated collection and prevent the electron recombination in the backside of the  $\text{Sb}_2\text{Se}_3$  cells. As expected, the device performances extracted from the current density–voltage ( $J$ - $V$ ) curves (Fig. 3c) demonstrate that the  $\text{NiO}_x$  HTL can effectively improve the PCE to 7.29% with both increased open-circuit voltage and short circuit current. The detailed device parameters are summarized in Table 1. The  $\text{NiO}_x$  thickness optimization to achieve the best device performance will be discussed in detail later.

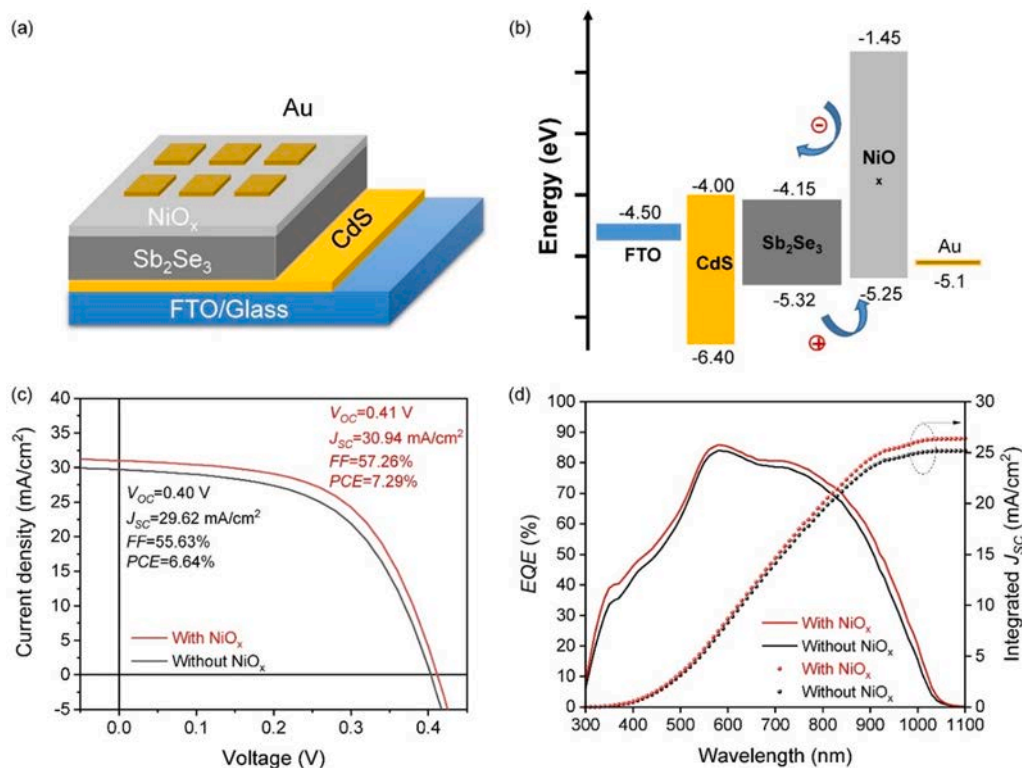
The incorporation of  $\text{NiO}_x$  HTL in the  $\text{Sb}_2\text{Se}_3$  device directly enhances the EQE throughout the entire visible spectrum, as shown in Fig. 3d. Particularly, both the short and long wavelength light absorption became stronger, suggesting that the  $\text{NiO}_x$  HTL promotes the light conversion to electrons and holes and also through the electron

**Table 1**Champion Device parameters of  $\text{Sb}_2\text{Se}_3$  solar cells with and without  $\text{NiO}_x$  HTL.

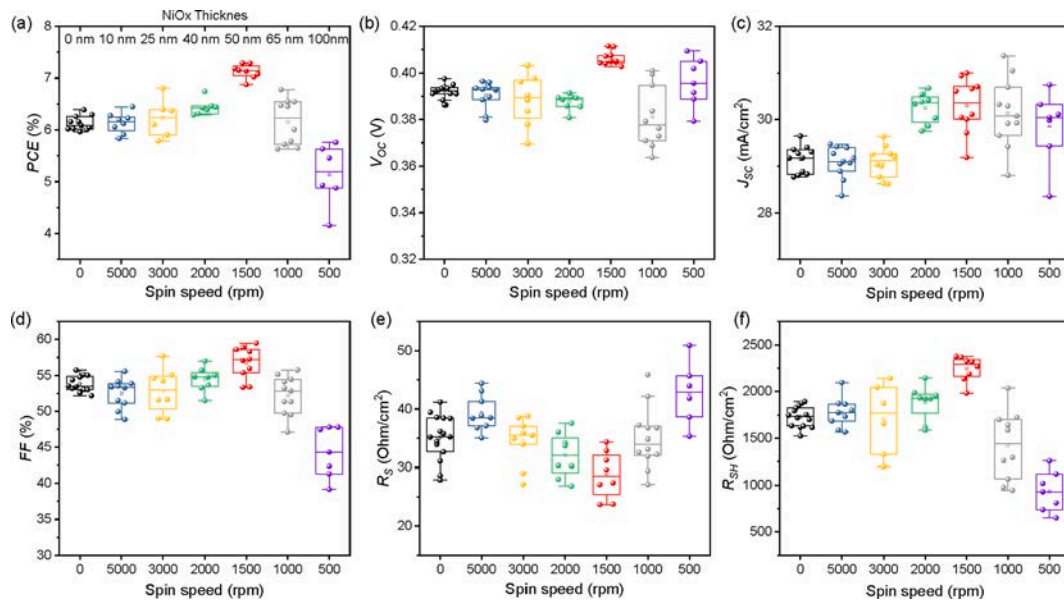
Samples	Voc, V	Jsc, mA/cm <sup>2</sup>	FF, %	PCE, %
Without NiOx	0.40	29.62	55.63	6.64
With NiO	0.41	30.94	57.26	7.29

reflection and hole collection via the desired band alignment as shown in Fig. 3b. The integrated  $J_{SC}$  of solar cells with/without  $\text{NiO}_x$  are 26.36 and 25.12 mA/cm<sup>2</sup>, respectively, suggesting that the  $\text{NiO}_x$  could effectively extract the photogenerated holes. However, the integrated  $J_{SC}$  from EQE is lower than that of the  $J_{SC}$  values from the  $J$ - $V$  curves ( $\sim 10\%$  lower). This  $J_{SC}$  offset between the EQE and  $J$ - $V$  measurement is normally associated with the interface quality of the  $\text{Sb}_2\text{Se}_3$  and the back contact. Here, we employ sputtering deposition of Au electrode, which has stronger ionic energy during deposition and may damage the  $\text{Sb}_2\text{Se}_3$  and  $\text{NiO}_x/\text{Sb}_2\text{Se}_3$  surface compared to the traditional thermal evaporation deposited Au electrode. Therefore, it is expected that the EQE is more sensitive to the interface quality. The interface quality using the sputtered Au electrode on  $\text{Sb}_2\text{Se}_3$  will be investigated in the future.

To screen the optimal thickness of the  $\text{NiO}_x$  HTL, we deposited  $\text{NiO}_x$  on the  $\text{Sb}_2\text{Se}_3$  film with varying rotation speed ranging from 0 to 5000 rpm to obtain different thicknesses (Fig. 4a). Fig. 4a shows the statistical distribution of the PCE with different  $\text{NiO}_x$  thicknesses. Note that the device performance increases with increasing  $\text{NiO}_x$  thickness from 0 nm to 50 nm from an average PCE of 6.12% to 7.15%, while PCE decreases with further increase in the  $\text{NiO}_x$  thickness to 100 nm with an average PCE of 5.2%. Particularly, the change of  $J_{SC}$  and FF is consistent with the  $\text{NiO}_x$  thickness variation and dominates the device performance improvement. It is observed that the Voc was significantly improved with the insertion of 50 nm  $\text{NiO}_x$ , suggesting an improved hole collection via an optimized band alignment between  $\text{Sb}_2\text{Se}_3/\text{NiO}_x/\text{Au}$ . Also, incorporation of the  $\text{NiO}_x$  HTL in solar cells also boosts  $J_{SC}$  owing to the enhanced photogenerated current generation as shown in the EQE curve



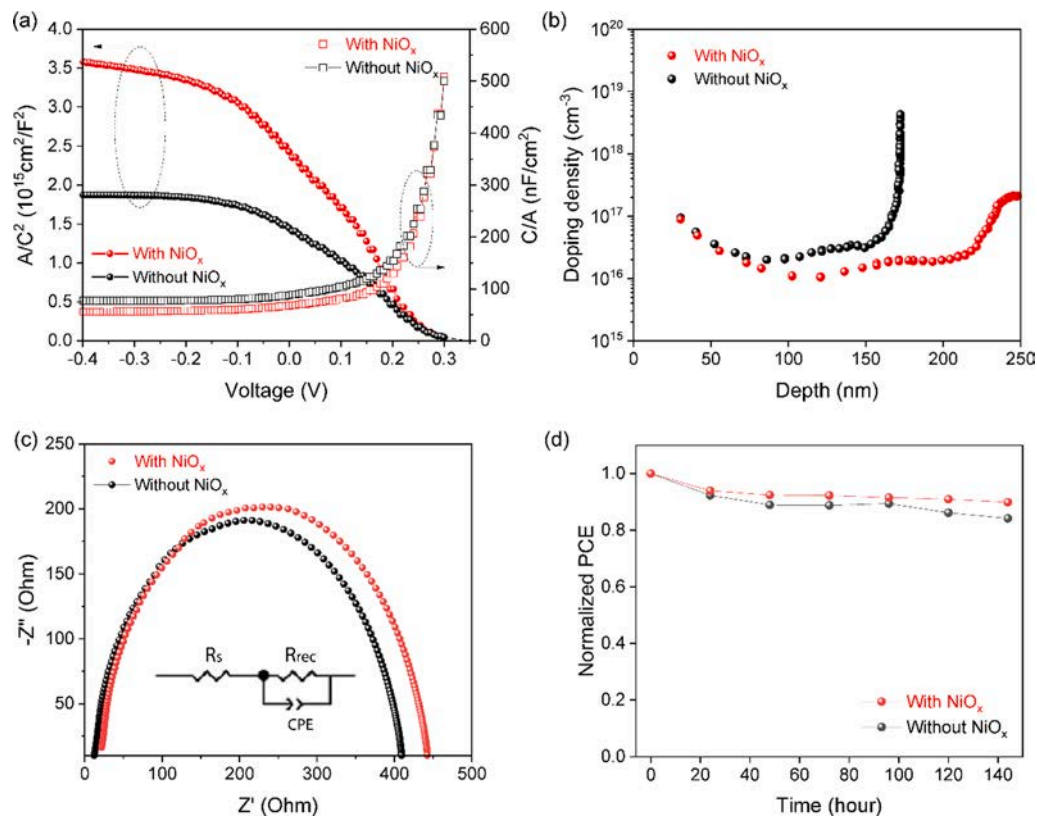
**Fig. 3.** (a) Schematic illustration of  $\text{Sb}_2\text{Se}_3$  device configuration (b) Schematic of the energy band diagram of the  $\text{Sb}_2\text{Se}_3$  cells with  $\text{NiO}_x$  hole transport layer. (c)  $J$ - $V$  curves and (d) EQE spectra of the champion  $\text{Sb}_2\text{Se}_3$  cells with and without  $\text{NiO}_x$  layer.



**Fig. 4.** Statistical distributions of (a) PCE, (b)  $V_{OC}$ , (c)  $J_{SC}$ , (d) FF, (e)  $R_s$ , and (f)  $R_{SH}$  of  $\text{Sb}_2\text{Se}_3$  solar cells with  $\text{NiO}_x$  as the HTL with various thickness by tailoring spin coating rotation speed (Thickness are indexed in Fig. 4a).

in the full visible sunlight spectrum and better quality of interfaces among  $\text{Sb}_2\text{Se}_3/\text{NiO}_x/\text{Au}$ . Particularly, the series resistivity ( $R_s$ ) of the device with  $\text{NiO}_x$  thickness less than 50 nm is gradually reduced, which contributes to the improved average FF up to 57.3%. With a thicker  $\text{NiO}_x$  HTLs of more than 50 nm, it is shown that the  $R_s$  greatly increases, leading to reduced PCE, FF,  $J_{sc}$ , and shunting resistivity ( $R_{sh}$ ). It is expected that the thick  $\text{NiO}_x$  may block the photoinduced holes collection by the Au electrode.

To determine the carrier concentration and the carrier transport capability in the  $\text{Sb}_2\text{Se}_3$  device with  $\text{NiO}_x$  HTL, the C-V measurement was performed. Fig. 5a. shows the Mott-Schottky plot of both the  $\text{Sb}_2\text{Se}_3$  solar cell devices with and without  $\text{NiO}_x$ . It is observed that the built-in potential ( $V_{bi}$ ) is about 0.32 V for both devices, which indicates that the  $\text{NiO}_x$  HTL may not change the  $V_{bi}$  too much and in agreement with only slightly improved Voc. However, at the 0 V bias, the capacitance of the  $\text{Sb}_2\text{Se}_3$  device with  $\text{NiO}_x$  possesses a smaller capacitance value than that



**Fig. 5.** (a)  $A/C^2$  and  $C/A$  versus applied voltage (V) graphs; (b) logarithmic representation of a C-V derived carrier density profiles, and (c) Nyquist plots for the  $\text{Sb}_2\text{Se}_3$  cells with and without  $\text{NiO}_x$  hole transport layer. (d) Light soaking stability test (85 °C, 1 sun solar simulator).

of the device without NiO<sub>x</sub>. The width of the depletion region of the devices can be determined through the capacitance–voltage formula,  $W = A\epsilon\epsilon_0/C_0$ , where  $A$  is electrode area,  $\epsilon$  is the permittivity,  $\epsilon_0$  is the vacuum permittivity, and  $C_0$  is the capacitance at 0 V bias (Yan, 2018). The calculated width of the depletion region is shown in Fig. 5b, where the NiO<sub>x</sub> HTL significantly improved the depletion region from 165 nm to 225 nm compared to that of the device without NiO<sub>x</sub>. The increased depletion region could be ascribed to the formed n-i-p heterojunction, which benefits the carrier generation and extraction (Guo et al., 2019). The charge carrier density ( $N_{CV}$ ) profile as a function of the distance from the junction is calculated based on the equation:  $N_{CV}(D) = \frac{2}{q\epsilon A^2} \left[ \frac{dC(V)^{-2}}{dV} \right]^{-1}$ , where  $q$  is the electron charge,  $\epsilon$  is the semiconductor

permittivity,  $A$  is the cell area, and  $\frac{dC(V)^{-2}}{dV}$  is the slope of the curve  $C^{-2}$ -V curve shown in Fig. 5(a).  $D$  is the depth of the junction, which can be calculated from  $D = \frac{\epsilon A}{C}$ . Fig. 5(b) shows the  $C$ -V doping profiling for the devices with and without NiO<sub>x</sub>. Particularly, the NiO<sub>x</sub> HTL did not impact the hole density in the devices, which is  $\sim 2 \times 10^{16} \text{ cm}^{-3}$  at 0 V bias, suggesting that the Ni or O ions may not diffuse into the device as dopants.

To better understand the role of NiO<sub>x</sub> on the interface charge transport, EIS was employed to characterize the Sb<sub>2</sub>Se<sub>3</sub> devices with and without NiO<sub>x</sub> HTL. Fig. 5c shows the Nyquist plots of the devices with/without the NiO<sub>x</sub> HTL. An equivalent circuit (inset of Fig. 5c) with series resistance ( $R_s$ ), a charge recombination resistance ( $R_{rec}$ ), and a constant phase angle element (CPE) was used to fit the semicircle. The fitting results are shown in Table 2. Since the CdS, Sb<sub>2</sub>Se<sub>3</sub>, and Au electrodes are the same in both devices, the variation of the semicircle may originate from the interface of Sb<sub>2</sub>Se<sub>3</sub>/NiO<sub>x</sub>/Au, where a larger  $R_{rec}$  suggests a lower charge recombination interface with NiO<sub>x</sub> HTL. In other words, NiO<sub>x</sub> HTL could effectively suppress the carrier recombination at the backside of the Sb<sub>2</sub>Se<sub>3</sub> device. To evaluate the stability with the NiO<sub>x</sub> HTL of the Sb<sub>2</sub>Se<sub>3</sub> solar cells, an accelerated stress test of the device stability under light soaking at 85 °C and 1 sun (100 mW cm<sup>-2</sup>) was carried out (Fig. 5d). Overall, the Sb<sub>2</sub>Se<sub>3</sub> device with/without NiO<sub>x</sub> retains 80% of the initial efficiency after about 140 h, suggesting both devices show good stability under accelerated stress. Particularly, with the NiO<sub>x</sub> HTL, the degradation rate for the device is slower compared to that of the device without NiO<sub>x</sub>, indicating that NiO<sub>x</sub> HTL could improve device stability.

#### 4. Conclusions

In summary, NiO<sub>x</sub> as an effective HTL for Sb<sub>2</sub>Se<sub>3</sub> thin-film solar cells has been demonstrated. NiO<sub>x</sub> nanoparticle was successfully synthesized to form NiO<sub>x</sub> ink, which can be directly spin-coated on the Sb<sub>2</sub>Se<sub>3</sub> films at a low cost. NiO<sub>x</sub> HTL can significantly improve the device performance of the Sb<sub>2</sub>Se<sub>3</sub> solar cells from PCE of 6.12% to 7.15% by tailoring the NiO<sub>x</sub> thickness. NiO<sub>x</sub> HTL not only enhances the carrier collection via the electron reflection effect but also suppresses carrier recombination at the Sb<sub>2</sub>Se<sub>3</sub>/NiO<sub>x</sub>/Au interface. This work provides a cost-effective, nontoxic hole-transporting material for Sb<sub>2</sub>Se<sub>3</sub> solar cells, which paves the way to further developing more efficient Sb<sub>2</sub>Se<sub>3</sub> solar cells by the introduction of hole transport materials.

#### Author contributions

Prof. Feng Yan designed the research and Liping Guo, N. Vijayaraghavan, Xiaomeng Duan and Harigovind G. Menon performed research, analyzed data, and revised the manuscript. Prof. Lingyan Kong, Subhadra Gupta, and Lin Li helped performed research and review & edit the manuscript.

**Table 2**

Fitting parameters of EIS results by using a R(CR) equivalent circuit.

Samples	$R_s$ , $\Omega \text{ cm}^2$	CPE, $\text{F/cm}^2$	$R_{rec}$ , $\Omega \text{ cm}^2$	CPE-P
Without NiO <sub>x</sub>	17.6	$2.53 \times 10^{-8}$	392.5	0.94
With NiO <sub>x</sub>	15.9	$1.31 \times 10^{-8}$	594.5	0.94

#### Declaration of Competing Interest

The authors declare that they have no known competing financial interests or personal relationships that could have appeared to influence the work reported in this paper.

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